Unit: mm

6.0±0.2

11-5K1S

TOSHIBA PHOTOCOUPLER IRED & PHOTO-IC

TLP2166A

Plasma Display Panels (PDPs)

High-Speed Interfaces

3.3-V Voltage Source

The Toshiba TLP2166A consists of an infrared emitting diode and an integrated high-gain, high-speed photodetector. The TLP2166A is housed in the 8-pin SO package. Since the TLP2166A contains two photocouplers, it saves board space.

The TLP2166A operates with a 3.3-V supply voltage.

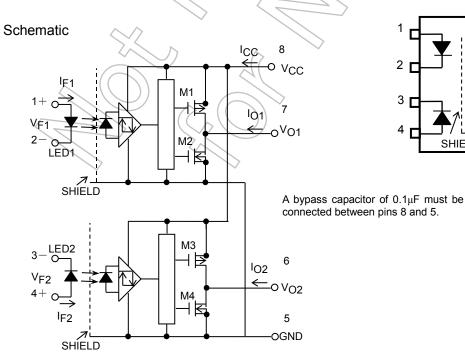
- Inverting logic output (totem-pole output)
- SO8 package
- Guaranteed performance over -40 to 100°C
- Power supply voltage: 3.0 to 3.6 V
- Input threshold current: I_{FHL} = 3 mA (max)
- Switching time (t_{pHL} / t_{pLH}): 75 ns (max)
- Switching speed: 15 MBd (typ.)(NRZ)
- Common-mode transient immunity: ±15 kV/µs
- Isolation voltage: 2500 V_{rms}
- UL-recognized: UL 1577, File No.E67349
- cUL-recognized: CSA Component Acceptance Service No.5A File No.E67349
- VDE-approved: EN 60747-5-5 (Note 1)

Note 1 : When a VDE approved type is needed, please designate the **Option(V4)**.

Truth Table

í.					
	Input	LED1(2)	M1(3)	M2(4)	Output 1(2)
	Н	ON	OFF	ON	L ((/
	L	OFF	/ ON	OFF	H H
			$\langle \langle \rangle$	-	

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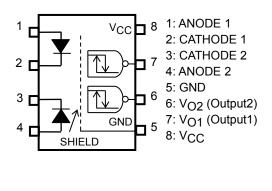
Pin Configuration (Top View)

0.38±0.1 1.27±0.15

JEDEC

JEITA 🦳 TOSHIBA

Weight: 0.11 g (typ.)



Start of commercial production 2008-07

Absolute Maximum Ratings (Ta=25°C)

	CHARACTERISTIC		SYMBOL	RATING	UNIT
	Forward Current	(Note 1)	lF	15	mA
	Forward Current Derating (Ta \ge 95°C)	(Note 1)	⊿I _F /⊿Ta	-0.5	mA/°C
ED	Peak Transient Forward Current	(Note 1, 2)	IFP	1	А
Ц	Reverse Voltage	(Note 1)	VR	5	V
	Input Power Dissipation	(Note 1)	PD	40	mW
	Input Power Dissipation Derating (Ta \ge 95°C)	(Note 1)	⊿P _D /°C	-1.3	mW/°C
	Output Current	(Note 1)	lo 🔨	10 (7)	mΑ
DETECTOR	Output Voltage	(Note 1)	Vo	6	∕∕v
Ъ Ц	Supply Voltage		Vcc	6	V
DET	Output Power Dissipation		Po	40	mW
	Output Power Dissipation Derating (Ta \geq 25°C)		⊿Po/°C	-0.4	mW/°C
Oper	ating Temperature Range		Topr	-40 to 100	°C
Stora	ge Temperature Range		Tstg	-55 to 125	°C
Lead	Soldering Temperature	(10 s)	Tsol	260 🔷	
Isolat	ion Voltage (AC, 60 s, R.H. \leq 60 %)	(Note 3)	BVs	2500	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Each Channel.
- Note 2: Pulse width \leq 1 $\mu s,$ 300 pps.
- Note 3: This device is regarded as a two terminal device: pins 1, 2, 3 and 4 are shorted together, as are pins 5, 6, 7 and 8.

Recommended Operating Conditions

	SYMBOL	MHN	TYP.	MAX	UNIT
(Note 1)	IF(ON)	5		10	mA
(Note 1)	V _{F(OFF)}	0		0.8	V
(Note 4)	Vcc	3.0	3.3	3.6	V
		-40		100	°C
	(Note 1)	(Note 1) IF(ON) (Note 1) VF(OFF) (Note 4) VCC	(Note 1) IF(ON) 5 (Note 1) VF(OFF) 0 (Note 4) VCC 3.0	(Note 1) IF(ON) 5 — (Note 1) VF(OFF) 0 — (Note 4) VCC 3.0 3.3	(Note 1) IF(ON) 5 — 10 (Note 1) VF(OFF) 0 — 0.8 (Note 4) VCC 3.0 3.3 3.6

* This item denotes operating range, not meaning of recommended operating conditions.

Note 4: The detector of this product requires a power supply voltage (VCC) of 3.0 V or higher for stable operation. If the VCC is lower than this value, an ICCH may increase, or an output may be unstable.

Be sure to use the product after checking the supply current, and the operation of a power-on/-off

Note: A ceramic capacitor (0.1 μF) should be connected from pin 8 (VCC) to pin 5 (GND) to stabilize the operation of the high gain linear amplifier. Failure to provide the bypass may impair the switching property.

The total lead length between capacitor and coupler should not exceed 1 cm.

Electrical Characteristics (Unless otherwise specified, Ta = -40 to 100 °C, V_{CC} = 3.0 to 3.6 V)

Characteristic		Symbol	Test Circuit	Condition	Min	Тур.	Max	Unit
Input Forward Voltage	(Note 1)	VF	_	I _F = 10 mA, Ta = 25 °C	1.3	1.65	1.75	V
Temperature Coefficient of Forward Voltage	(Note 1)	ΔV _F /ΔTa	_	IF = 10 mA	$\left \right\rangle$	-2.0	_	mV/°C
Input Reverse Current	(Note 1)	IR		V _R = 5 V, Ta = 25 °C	4	ノ	10	μA
Input Capacitance	(Note 1)	Ст		V = 0 V, f = 1 MHz, Ta = 25 °C	7/4	45		pF
Logic Low Output Voltage	(Note 1)	V _{OL}	1	I _{OL} =1.6 mA, I _F = 10 mA, V _{CC} = 3.3 V	\mathbb{Z}	0.3	0.6	v
Logic High Output Voltage	(Note 1)	Vон	2	I _{OH} = -0.02 mA, V _F = 1.05 V V _{CC} = 3.3 V	2.0	2.6		v
Logic Low Supply Current		ICCL	3	IF = 10 mA	_	7.0	10.0	mA
Logic High Supply Current		Іссн	4	V _F = 0 V (Note 4)	- /	4.0	10.0	mA
Operating Supply Voltage		V _{CC}		$(\vee \not \perp)) \land$	3.0	\mathcal{A}	3.6	V
Input Current Logic Low Output	(Note 1)	I _{FHL}	—	I _O = 1.6 mA, V _O < 0.6 V			3	mA
Input Voltage Logic High Output	(Note 1)	V _{FLH}		$I_0 = -0.02 \text{ mA}, V_0 > 2.0 \text{ V}$	0.8	_		V

*All typical values are at Ta=25°C.

Isolation Characteristics (Ta = 25°C)

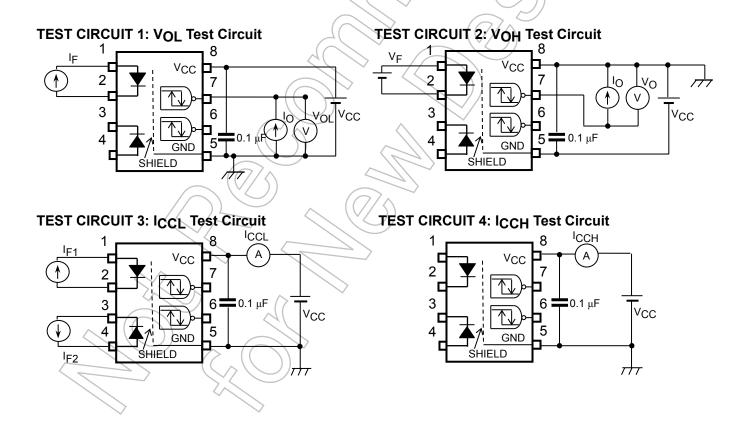
Characteristic	Symbol	Test Condition		Min	Тур.	Max	Unit
Capacitance input to output	Cs	V _S = 0 V, f = 1 MHz	(Note 3)	_	0.8	-	pF
Isolation resistance	Rs	$R.H. \leq 60~\%, V_S = 500~V$	(Note 3)	1×10 ¹²	10 ¹⁴	_	Ω
Isolation voltage	BVs	AC, 60 s	(Note 3)	2500	_	_	V _{rms}

Switching Characteristics

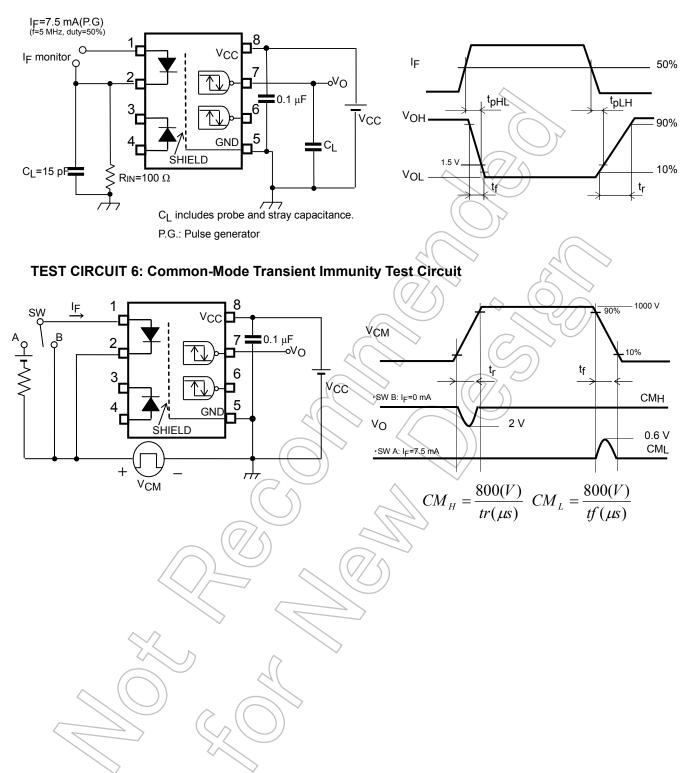
Characteristic	Symbol	Test Circuit	Conc	lition	Min	Тур.	Max	Unit
Propagation Delay Time to Logic Low output	t _{pHL}		I _F = 0→7.5 mA	R _{IN} = 100 Ω - C _L = 15 pF	2	_	75	ns
Propagation Delay Time to Logic High output	tрLН		I _F = 7.5→0 mA	(Note 6)		X	75	ns
Switching Time Dispersion between ON and OFF	tpHL-tpLH	5	5 I _F = 7.5 mA, R _{IN} = 100 Ω, C _L = 15 pF (Note 6)		$\overline{7}$		45	ns
Fall Time (90 – 10 %)	tf		IF = 0→7.5 mA	R _{IN} = 100 Ω		5	—	ns
Rise Time (10 – 90 %)	tr		IF = 7.5→0 mA	CL = 15 pF (Note 6)		5	_	ns
Common Mode transient Immunity at High Level Output	CM _H	_	V _{CM} = 1000 V _{p-p} V _O (min) = 2 V, Ta		15000	_	\mathcal{N}	V/μs
Common Mode transient Immunity at Low Level Output	CML	6	V_{CM} = 1000 V_{p-p} $V_{O}(max)$ = 0.6 V,	\frown	-15000	AC AC		V/µs

*All typical values are at Ta = 25 °C, V_{CC} = 3.3 V.

Note 6: CL is approximately 15 pF which includes probe and jig/stray wiring capacitance.



TEST CIRCUIT 5: Switching Time Test Circuit



Specification for Embossed–Tape Packing (TP) for SO8 Coupler

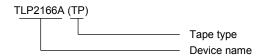
1. Applicable Package

Package	Product Type
SO8	Photocoupler

2. Product Naming System

Type of package used for shipment is denoted by a symbol suffix after a product number. The method of classification is as below.

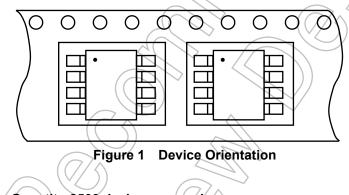
(Example)



3. Tape Dimensions

3.1 Orientation of Device in Relation to Direction of Tape Movement

Device orientation in the recesses is as shown in Figure 1.



- 3.2 Tape Packing Quantity:2500 devices per reel
- 3.3 Empty Device Recesses Are as Shown in Table 1.

Table 1 Empty Device Recesses

\sim		Standard	Remarks
	Occurrences of 2 or more successive empty device recesses	0 device	Within any given 40-mm section of tape, not including leader and trailer
	Single empty device recesses	6 devices (max) per reel	Not including leader and trailer

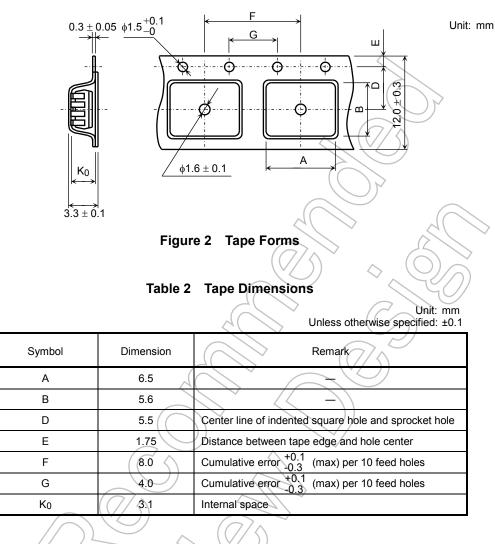
3.4 Start and End of Tape

The start of the tape has 50 or more empty holes. The end of tape has 50 or more empty holes and two empty turns only for a cover tape.

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3.5 Tape Specification

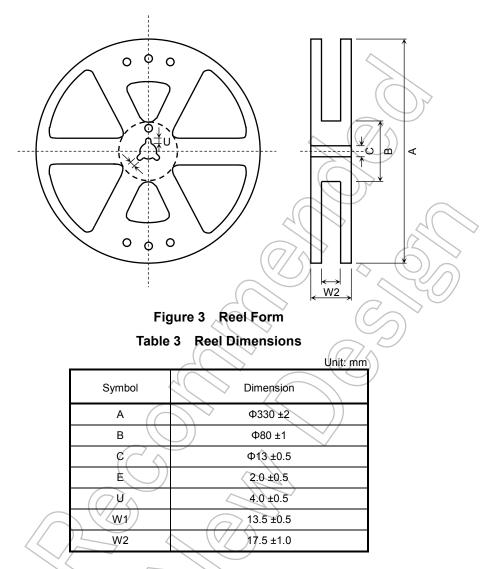
- (1) Tape material: Plastic (protection against electrostatics)
- (2) Dimensions: The tape dimensions are as shown in Figure 2 and table 2.



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3.6 Reel

- (1) Material: Plastic (protection against electrostatics)
- (2) Dimensions: The reel dimensions are as shown in Figure 3 and Table 3.



4. Packing

Packed in a shipping carton.

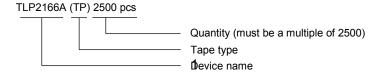
5. Label Indication

The carton bears a label indicating the product number, the symbol representing classification of standard, the quantity, the lot number and the Toshiba company name.

6. Ordering Method

When placing an order, please specify the product number, the tape type and the quantity as shown in the following example.

(Example)

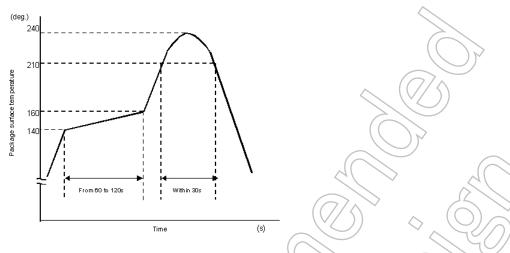


Precautions of Surface Mounting Type Photocoupler Soldering & General Storage

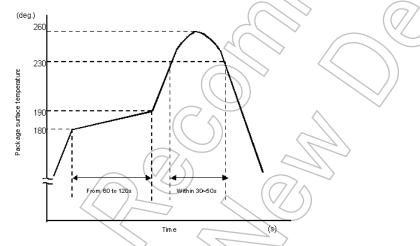
(1) Precautions for Soldering

1) When Using Soldering Reflow

• An example of a temperature profile when Sn-Pb eutectic solder is used:



An example of a temperature profile when lead(Pb)-free solder is used:



- Reflow soldering must be performed once or twice.
- The mounting should be completed with the interval from the first to the last mountings being 2 weeks.

2) When using soldering Flow (Applicable to both eutectic solder and Lead(Pb)-Free solder)

- Apply preheating of 150 °C for 60 to 120 seconds.
- Mounting condition of 260 °C or less within 10 seconds is recommended.
- Flow soldering must be performed once

3) When using soldering Iron (Applicable to both eutectic solder and Lead(Pb)-Free solder)

- Complete soldering within 10 seconds for lead temperature not exceeding °C or within 3 seconds not exceeding 350 °C.
- Heating by soldering iron must be only once per 1 lead

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(2) Precautions for General Storage

- 1) Do not store devices at any place where they will be exposed to moisture or direct sunlight.
- 2) When transportation or storage of devices, follow the cautions indicated on the carton box.
- 3) The storage area temperature should be kept within a temperature range of 5 °C to 35 °C, and relative humidity should be maintained at between 45% and 75%.
- 4) Do not store devices in the presence of harmful (especially corrosive) gases, or in dusty conditions.
- 5) Use storage areas where there is minimal temperature fluctuation. Because rapid temperature changes can cause condensation to occur on stored devices, resulting in lead oxidation or corrosion, as a result, the solderability of the leads will be degraded.
- 6) When repacking devices, use anti-static containers.
- 7) Do not apply any external force or load directly to devices while they are in storage.
- 8) If devices have been stored for more than two years, even though the above conditions have been followed, it is recommended that solderability of them should be tested before they are used.

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